<u>1</u> of <u>1</u> Sheet U.S. DEPARTMENT OF COMMERCE ATTY. DOCKET NO. PATENT AND TRADEMARK OFFICE NIT-320-02 FORM PTO-1449 SERIAL NO. (REV. 7-80) APPLICANT LIST OF DOCUMENTS CITED BY APPLICANT M. MOCHIZUKI et al (Use several sheets if necessary) FILING DATE GROUP 02/10/04 2652 **U.S. PATENT DOCUMENTS** EXAMINER FILING DATE (If Appropriate) DOCUMENT DATE NAME CLASS SUBCLASS INITIAL 6,504,675 01/2003 Shukh et al 5,995,341 11/1999 Tanaka et al 5,495,379 02/1996 McNeil et al AD 5,396,391 03/1995 Tanaka et al um ΑF AG ΑH ΑI ΑJ AK **FOREIGN PATENT DOCUMENTS** TRANSLATION DOCUMENT DATE COUNTRY CLASS SUBCLASS YES NO 11-213334 08/06/99 Japan AL ΑO ΑP OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.) **EXAMINER** DATE CONSIDERED

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